

Search Notes

Application/Control No.

09/834,165

Examiner

Yogesh K. Aggarwal

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
used the same references		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner